

TA Technology (Shanghai) Co., Ltd.
Test Report

No. RZA2008-0952FCC

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ANNEX E : PROBE CALIBRATION CERTIFICATE

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

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The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client ATL (Auden)

Certificate No: ET3-1531_Jan08

CALIBRATION CERTIFICATE

Object ET3DV6 - SN:1531

Calibration procedure(s) QA CAL-01_v6 and QA CAL-12_v5
Calibration procedure for dosimetric E-field probes

Calibration date: January 29, 2008

Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility, environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Calibrated by, Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	29-Mar-07 (METAS, No. 217-00670)	Mar-08
Power sensor E4412A	MY41495277	29-Mar-07 (METAS, No. 217-00670)	Mar-08
Power sensor E4412A	MY41498087	29-Mar-07 (METAS, No. 217-00670)	Mar-08
Reference 3 dB Attenuator	SN: S5054 (3c)	8-Aug-07 (METAS, No. 217-00719)	Aug-08
Reference 20 dB Attenuator	SN: S5058 (20b)	29-Mar-07 (METAS, No. 217-00671)	Mar-08
Reference 30 dB Attenuator	SN: S5129 (30b)	8-Aug-07 (METAS, No. 217-00720)	Aug-08
Reference Probe ES3DV2	SN: 3013	2-Jun-08 (SPEAG, No. ES3-3013_Jan08)	Jan-09
DAE4	SN: 654	20-Apr-07 (SPEAG, No. DAE4-654_Apr07)	Apr-08

Secondary Standards	ID #	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-09 (SPEAG, in house check Oct-07)	In house check: Oct-09
Network Analyzer HP 8753E	US37300585	18-Oct-01 (SPEAG, in house check Oct-07)	In house check: Oct-08

Calibrated by:	Name	Function	Signature
	Kaja Pokovic	Technical Manager	
Approved by:	Nils Kaiser	Quality Manager	

Issued: January 29, 2008

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Certificate No: ET3-1531_Jan08

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Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
NORM x,y,z	sensitivity in free space
ConF	sensitivity in TSL / NORM x,y,z
DCP	diode compression point
Polarization ϕ	ϕ rotation around probe axis
Polarization θ	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\theta = 0$ is normal to probe axis

Calibration Is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORM x,y,z : Assessed for E-field polarization $\theta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM x,y,z are only intermediate values, i.e., the uncertainties of NORM x,y,z does not effect the E²-field uncertainty inside TSL (see below ConF).
- $NORM(f)x,y,z = NORMx,y,z * frequency_response$ (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConF.
- DCP x,y,z : DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- *ConF and Boundary Effect Parameters*: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM $x,y,z * ConF$ whereby the uncertainty corresponds to that given for ConF. A frequency dependent ConF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- *Spherical Isotropy (3D deviation from isotropy)*: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- *Sensor Offset*: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

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ET3DV6 SN:1531

January 29, 2008

Probe ET3DV6

SN:1531

Manufactured: July 15, 2000
Last calibrated: January 22, 2007
Recalibrated: January 29, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

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ET3DV6 SN:1531

January 29, 2008

DASY - Parameters of Probe: ET3DV6 SN:1531

Sensitivity in Free Space^A

NormX	$1.52 \pm 10.1\%$	$\mu\text{V}/(\text{V}/\text{m})^2$
NormY	$1.66 \pm 10.1\%$	$\mu\text{V}/(\text{V}/\text{m})^2$
NormZ	$1.71 \pm 10.1\%$	$\mu\text{V}/(\text{V}/\text{m})^2$

Diode Compression^B

DCP X	95 mV
DCP Y	94 mV
DCP Z	93 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 900 MHz Typical SAR gradient: 5 % per mm

Sensor Center to Phantom Surface Distance	3.7 mm	4.7 mm
SAR _{be} [%] Without Correction Algorithm	8.3	4.5
SAR _{be} [%] With Correction Algorithm	0.7	0.0

TSL 1750 MHz Typical SAR gradient: 10 % per mm

Sensor Center to Phantom Surface Distance	3.7 mm	4.7 mm
SAR _{be} [%] Without Correction Algorithm	11.9	8.0
SAR _{be} [%] With Correction Algorithm	0.5	0.1

Sensor Offset

Probe Tip to Sensor Center **2.7 mm**

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Page 8).

^B Numerical linearization parameter: uncertainty not required.

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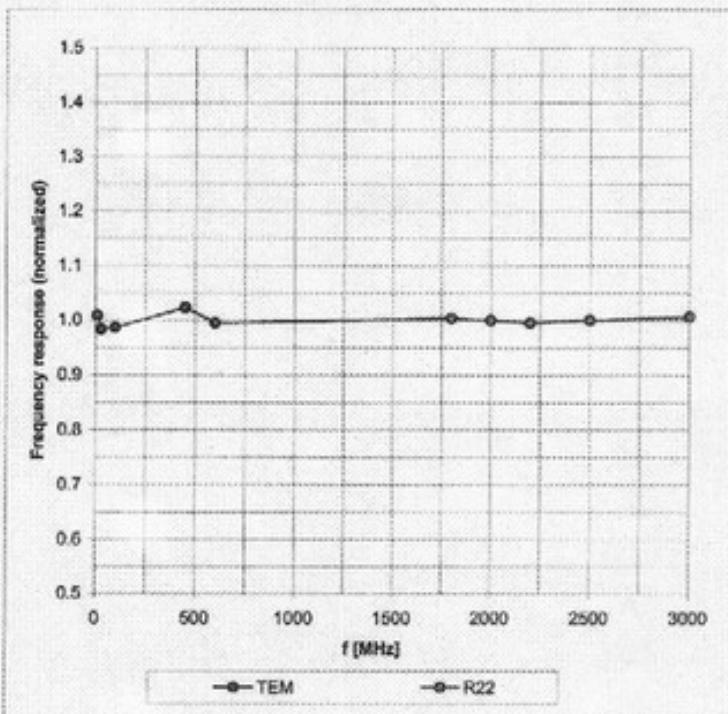
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Frequency Response of E-Field

(TEM-Cell: Ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

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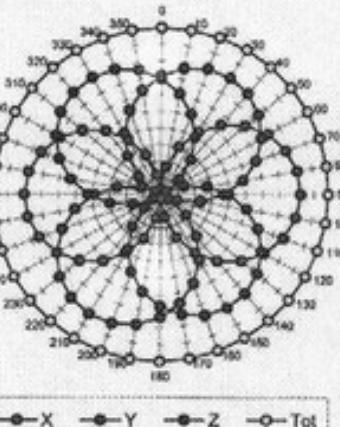
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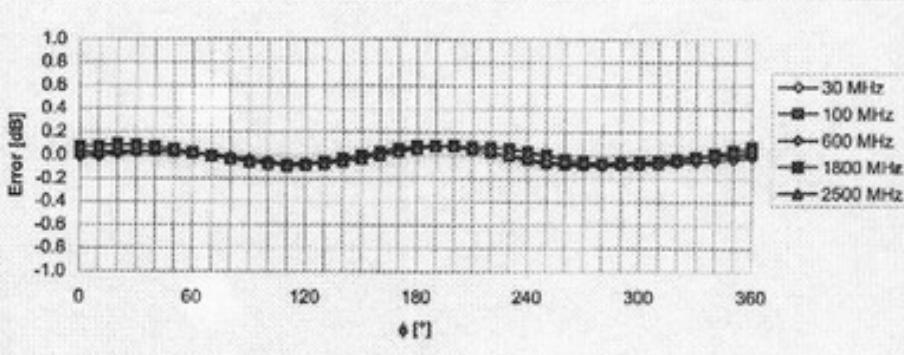
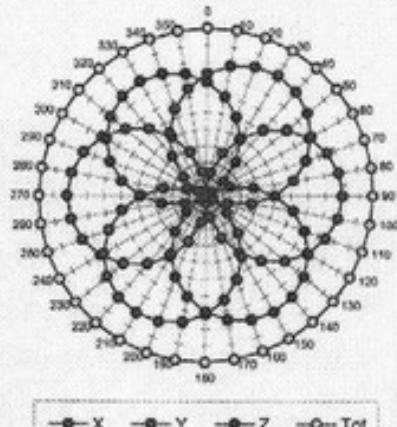
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Receiving Pattern (ϕ), $\theta = 0^\circ$

$f = 600 \text{ MHz, TEM ifi110EXX}$



$f = 1800 \text{ MHz, WG R22}$



Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

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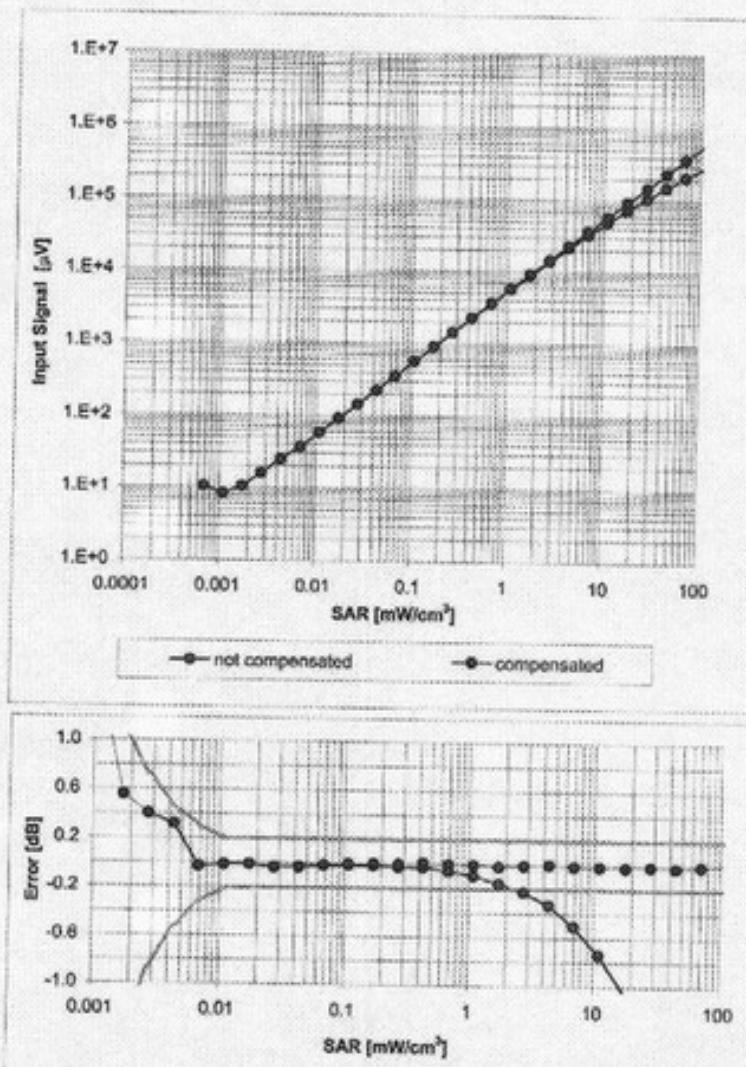
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Dynamic Range f(SAR_{head})
(Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment: ± 0.6% (k=2)

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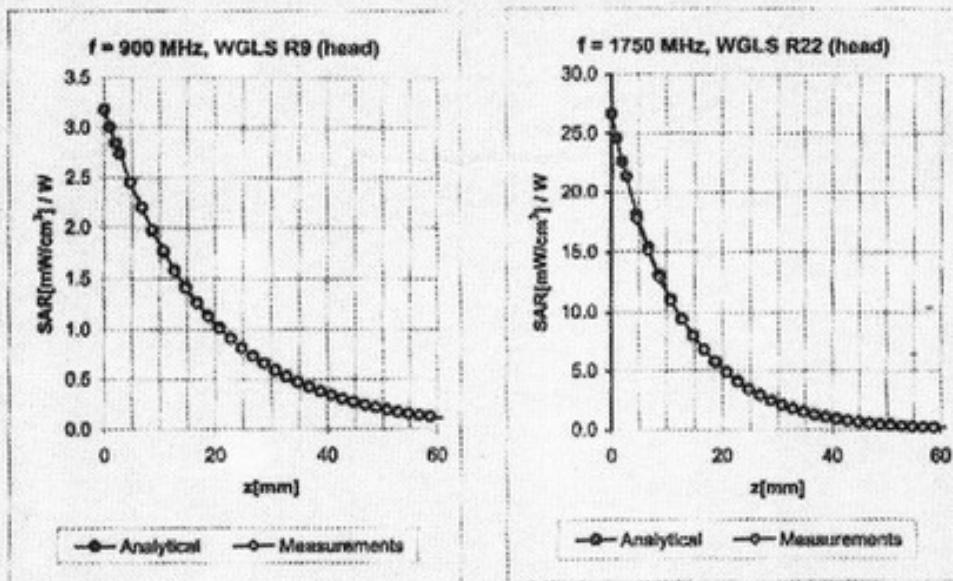
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Conversion Factor Assessment



f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
900	$\pm 50 / \pm 100$	Head	$41.5 \pm 5\%$	$0.97 \pm 5\%$	0.27	2.89	$6.85 \pm 11.0\% (\text{k}=2)$
1750	$\pm 50 / \pm 100$	Head	$40.1 \pm 5\%$	$1.37 \pm 5\%$	0.52	2.56	$5.42 \pm 11.0\% (\text{k}=2)$
1950	$\pm 50 / \pm 100$	Head	$40.0 \pm 5\%$	$1.40 \pm 5\%$	0.49	2.89	$5.15 \pm 11.0\% (\text{k}=2)$

900	$\pm 50 / \pm 100$	Body	$55.0 \pm 5\%$	$1.05 \pm 5\%$	0.35	2.82	$6.52 \pm 11.0\% (\text{k}=2)$
1750	$\pm 50 / \pm 100$	Body	$53.4 \pm 5\%$	$1.49 \pm 5\%$	0.56	2.68	$4.97 \pm 11.0\% (\text{k}=2)$
1950	$\pm 50 / \pm 100$	Body	$53.3 \pm 5\%$	$1.52 \pm 5\%$	0.88	2.07	$4.64 \pm 11.0\% (\text{k}=2)$
2450	$\pm 50 / \pm 100$	Body	$52.7 \pm 5\%$	$1.95 \pm 5\%$	0.66	2.16	$4.10 \pm 11.8\% (\text{k}=2)$

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

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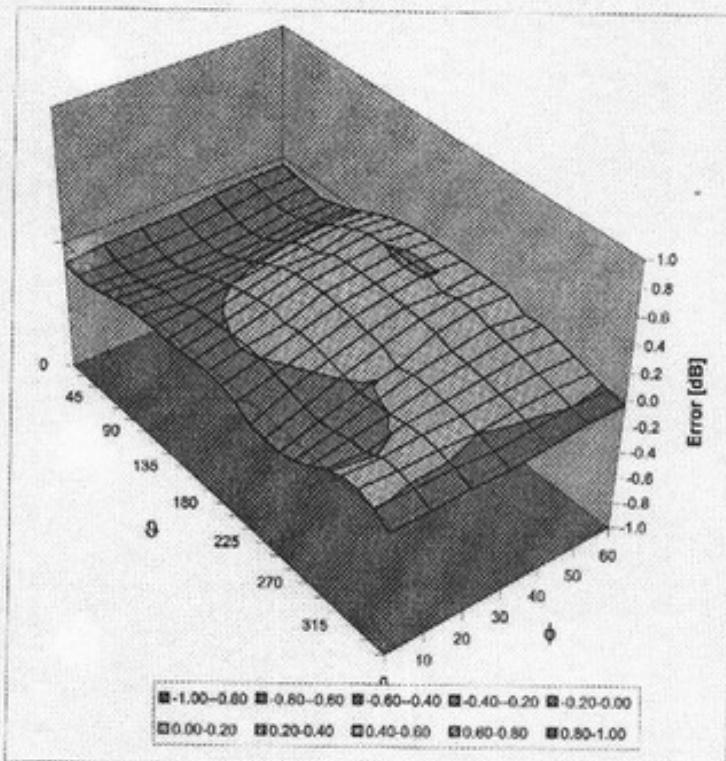
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January 29, 2008

Deviation from Isotropy in HSL

Error (ϕ, θ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: $\pm 2.6\%$ (k=2)

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ANNEX F : D835V2 DIPOLE CALIBRATION CERTIFICATE

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Accreditation No.: SCS 108

Client TMC China

Certificate No: D835V2-443_Dec07

CALIBRATION CERTIFICATE

Object	D835V2-SN: 443
Calibration procedure(s)	QA CAL-05.v6 Calibration procedure for dipole validation kits
Calibration date:	December 9, 2007
Condition of the calibrated item	In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements(SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted at an environment temperature (22±3)°C and humidity<70%

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Data (Calibrated by, Certification NO.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	13-Sep-07 (METAS, NO. 217-00608)	Sep-08
Power sensor 8481A	US37292783	13-Sep-07 (METAS, NO. 217-00608)	Sep-08
Reference 20 dB Attenuator	SN:5086 (20g)	12-Jul-07 (METAS, NO. 217-00591)	Jul-08
Reference 10 dB Attenuator	SN:5047_2 (10r)	12-Jul-07 (METAS, NO. 217-00591)	Jul-08
DAE4	SN:601	30-Jan-07 (SPEAG, NO.DAE4-601_Jan07)	Jan-08
Reference Probe ET3DV8 (HF)	SN: 1507	19-Sep-07 (SPEAG, NO. ET3-1507_Sep07)	Sep-08
Secondary Standards	ID#	Check Data (in house)	Scheduled Calibration
Power sensor HP 8481A	MY41092317	18-Oct-02(SPEAG, in house check Oct-07)	In house check: Oct-09
RF generator Agilent E4421B	MY41000878	11-May-05(SPEAG, in house check Nov-07)	In house check: Nov-09
Network Analyzer HP 8753E	US37390585S4208	18-Oct-01(SPEAG, in house check Oct-07)	In house check: Oct-08
Calibrated by:	Name	Function	Signature
Calibrated by:	Marcel Fehr	Laboratory Technician	
Approved by:	Name	Function	Signature
Approved by:	Katja Pokovic	Technical Director	

Issued: December 10, 2007

This calibration certificate shall not be reported except in full without written approval of the laboratory.

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Accreditation No.: SCS 108

Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) CENELEC EN 50361, "Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones (300 MHz - 3 GHz)", July 2001
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

- d) DASY4 System Handbook

Methods Applied and Interpretation of Parameters:

- **Measurement Conditions:** Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- **Antenna Parameters with TSL:** The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- **Feed Point Impedance and Return Loss:** These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- **Electrical Delay:** One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- **SAR measured:** SAR measured at the stated antenna input power.
- **SAR normalized:** SAR as measured, normalized to an input power of 1 W at the antenna connector.
- **SAR for nominal TSL parameters:** The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.80 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	40.2 ± 6 %	0.89 mho/m ± 6 %
Head TSL temperature during test	(21.2 ± 0.2) °C	—	—

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.43 mW / g
SAR normalized	normalized to 1W	9.72 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	9.70 mW / g ± 17.0 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.56 mW / g
SAR normalized	normalized to 1W	6.24 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	6.31 mW / g ± 16.5 % (k=2)

¹Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	50.5 Ω - 6.8 jΩ
Return Loss	- 25.8 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.402 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semi-rigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	September 3, 2001

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DASY4 Validation Report for Head TSL

Date/Time: 9.12.2007 14:20:15

Test laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; serial: D835V2-SN: 443

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: HSL 835 MHz;

Medium parameters used: $f=835 \text{ MHz}$; $\sigma=0.89 \text{ mho/m}$; $\epsilon_r=40.2$; $\rho=1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ET3DV6-SN1507(HF); ConvF(6.01,6.01,6.01); Calibrated: 19.9.2007
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 30.1._2007
- Phantom: Flat Phantom 4.9L; Type: QD000P49AA;
- Measurement SW: DASY, V4.7 Build 53; Post processing SW: SEMCAD, V1.8 Build 172

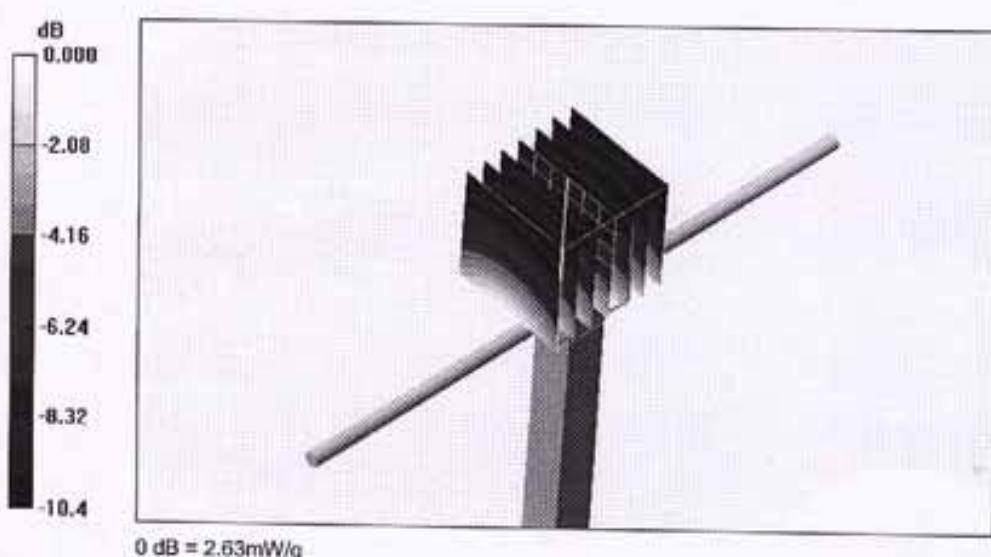
Pin = 250 mW; d = 15 mm/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 55.3 V/m; Power Drift = 0.015dB

Peak SAR (extrapolated) = 3.65 W/kg

SAR(1 g) = 2.43 mW/g; SAR(10 g) = 1.56 mW/g

Maximum value of SAR (measured) = 2.63 mW/g

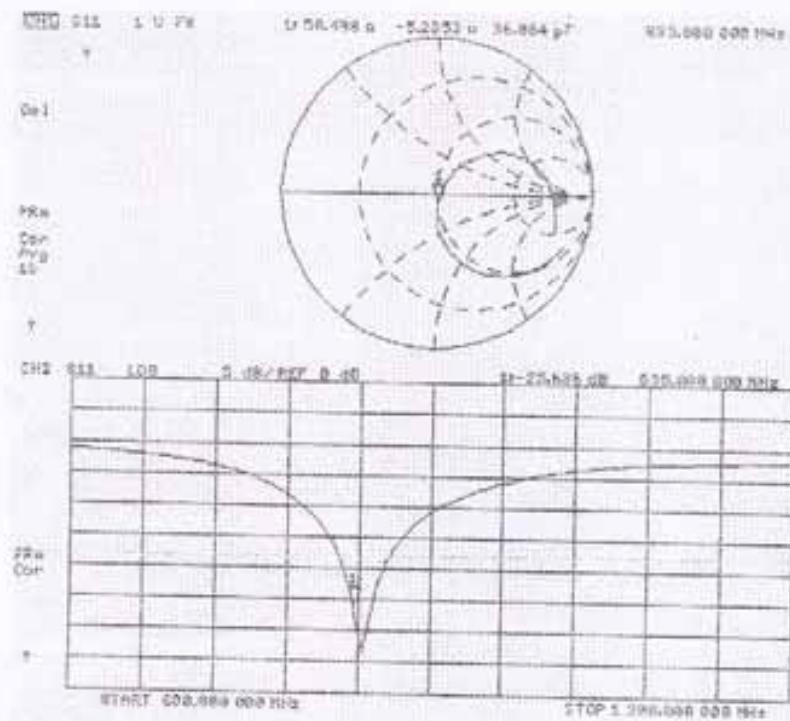


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Impedance measurement Plot for Head TSL



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ANNEX G : D1900V2 DIPOLE CALIBRATION CERTIFICATE

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Client **Auden**

Certificate No: D1900V2-5d018_Mar08

CALIBRATION CERTIFICATE

Object D1900V2 - SN: 5d018

Calibration procedure(s) QA CAL-05.v6
Calibration procedure for dipole validation kits

Calibration date: March 21, 2008

Condition of the calibrated item In Tolerance

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Reference Probe ET3DV6	SN: 1507	11-Sep-07 (SPEAG, No. ET3-1507_Sep07)	Sep-08
Reference Probe ES3DV3	SN: 3025	11-Sep-07 (SPEAG, No. ES3-3025_Sep07)	Sep-08
DAE4	SN 601	15-Jan-08 (SPEAG, No. DAE4-601_Jan08)	Jan-09
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (SPEAG, in house check Oct-07)	In house check: Oct-09
RF generator Agilent E4421B	MY41000675	11-May-05 (SPEAG, in house check Nov-07)	In house check: Nov-09
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (SPEAG, in house check Oct-07)	In house check: Oct-08

Calibrated by:	Name Claudio Leubler	Function Laboratory Technician	Signature
Approved by:	Katja Pokovic	Technical Manager	

Issued: March 22, 2008

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Additional Documentation:

- d) DASY4 System Handbook

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- *Antenna Parameters with TSL:* The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss:* These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay:* One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured:* SAR measured at the stated antenna input power.
- *SAR normalized:* SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters:* The measured TSL parameters are used to calculate the nominal SAR result.

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Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY4	V4.7
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	$dx, dy, dz = 5 \text{ mm}$	
Frequency	$1900 \text{ MHz} \pm 1 \text{ MHz}$	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.6 ± 6 %	1.43 mho/m ± 6 %
Head TSL temperature during test	(21.3 ± 0.2) °C	—	—

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	condition	
SAR measured	250 mW input power	9.45 mW / g
SAR normalized	normalized to 1W	37.8 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	36.4 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	4.98 mW / g
SAR normalized	normalized to 1W	19.9 mW / g
SAR for nominal Head TSL parameters ¹	normalized to 1W	19.5 mW / g ± 16.5 % (k=2)

¹ Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	53.3	1.52 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.0 ± 6 %	1.55 mho/m ± 6 %
Body TSL temperature during test	(21.3 ± 0.2) °C	—	—

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	9.63 mW / g
SAR normalized	normalized to 1W	38.5 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	36.8 mW / g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	5.21 mW / g
SAR normalized	normalized to 1W	20.8 mW / g
SAR for nominal Body TSL parameters ²	normalized to 1W	20.2 mW / g ± 16.5 % (k=2)

² Correction to nominal TSL parameters according to d), chapter "SAR Sensitivities"

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	52.5 Ω + 3.3 $j\Omega$
Return Loss	-27.9 dB

Antenna Parameters with Body TSL

Impedance, transformed to feed point	48.5 Ω + 2.9 $j\Omega$
Return Loss	-29.6 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.203 ns
----------------------------------	----------

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.
No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	June 4, 2002

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4

DASY4 Validation Report for Head TSL

Date/Time: 21.03.2008 15:30:20

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:5d018

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U10 BB;

Medium parameters used: $f = 1900 \text{ MHz}$; $\sigma = 1.43 \text{ mho/m}$; $\epsilon_r = 39.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ET3DV6 - SN1507 (HF); ConvF(4.97, 4.97, 4.97); Calibrated: 11.09.2007
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 15.01.2008
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:

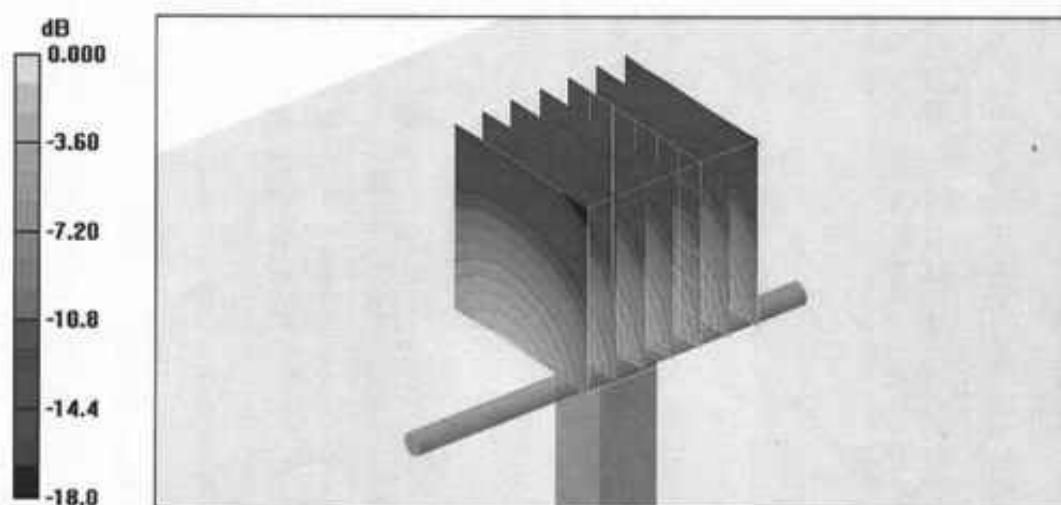
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 87.8 V/m; Power Drift = 0.057 dB

Peak SAR (extrapolated) = 16.2 W/kg

SAR(1 g) = 9.45 mW/g; SAR(10 g) = 4.98 mW/g

Maximum value of SAR (measured) = 10.7 mW/g



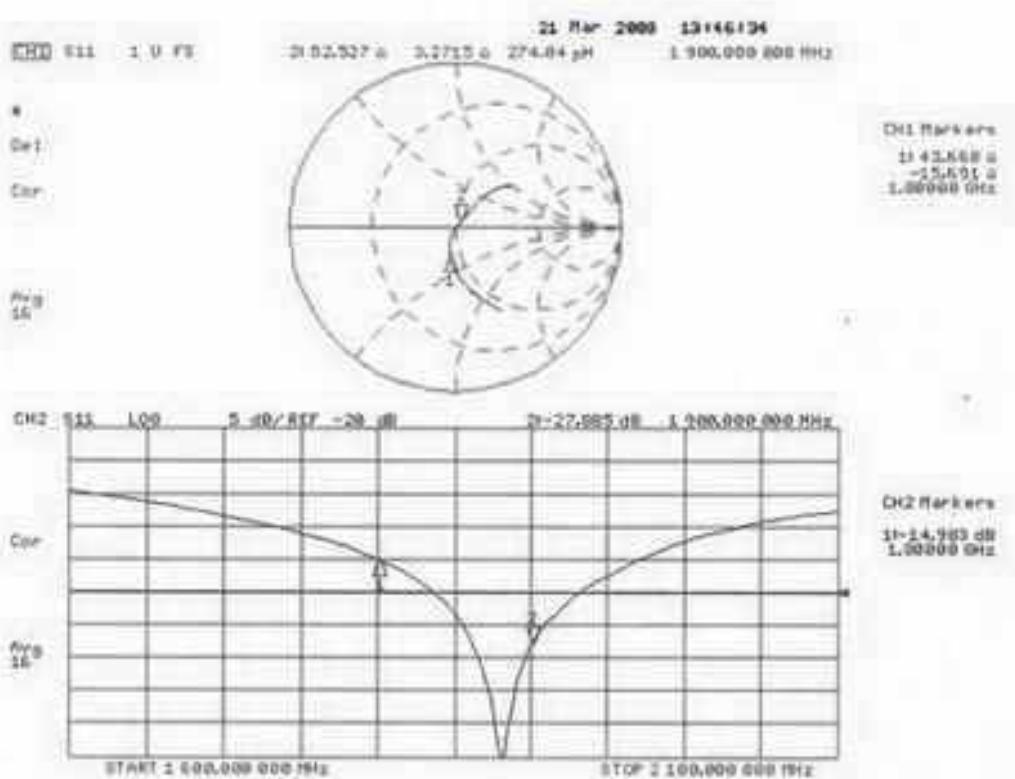
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Impedance Measurement Plot for Head TSL



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DASY4 Validation Report for Body TSL

Date/Time: 21.03.2008 16:41:02

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:5d018

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: MSL U10 BB;

Medium parameters used: $f = 1900 \text{ MHz}$; $\sigma = 1.55 \text{ mho/m}$; $\epsilon_r = 52$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: ET3DV6 - SN1507 (HF); ConvF(4.43, 4.43, 4.43); Calibrated: 11.09.2007
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 So601; Calibrated: 15.01.2008
- Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA
- Measurement SW: DASY4, V4.7 Build 53; Postprocessing SW: SEMCAD, V1.8 Build 172

Pin = 250 mW; d = 10 mm/Zoom Scan (7x7x7)/Cube 0:

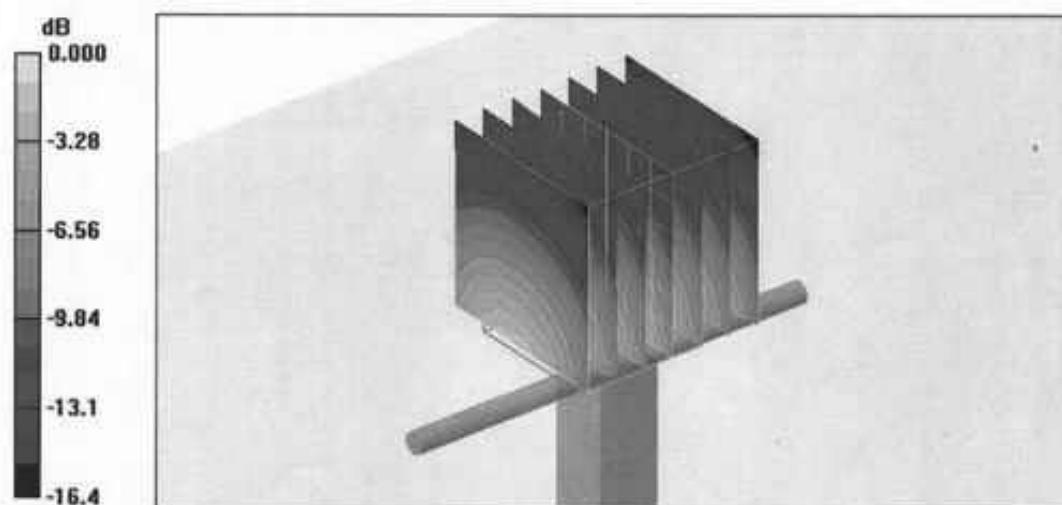
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 89.2 V/m; Power Drift = 0.021 dB

Peak SAR (extrapolated) = 16.1 W/kg

SAR(1 g) = 9.63 mW/g; SAR(10 g) = 5.21 mW/g

Maximum value of SAR (measured) = 11.3 mW/g

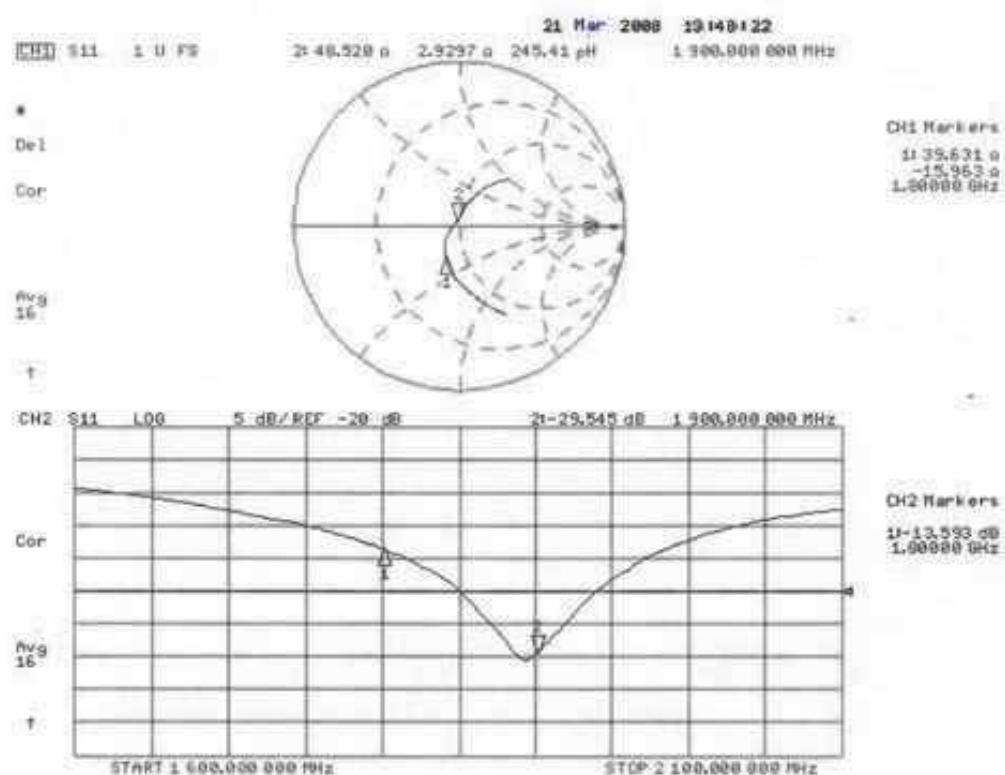


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Impedance Measurement Plot for Body TSL



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ANNEX H : DAE4 CALIBRATION CERTIFICATE

Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
C Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Client Auden

Certificate No: DAE4-679_May08

CALIBRATION CERTIFICATE

Object DAE4 - SD 000 D04 BA - SN: 679

Calibration procedure(s) QA CAL-06.v12
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: May 21, 2008

Condition of the calibrated item In Tolerance

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Fluke Process Calibrator Type 702	SN: 6295803	04-Oct-07 (No: 6467)	Oct-08
Keithley Multimeter Type 2001	SN: 0810278	03-Oct-07 (No: 6465)	Oct-08
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Calibrator Box V1.1	SE UMS 006 AB 1004	25-Jun-07 (in house check)	In house check: Jun-08

Calibrated by: Name Function Signature
Dominique Steffen Technician

Approved by: Name Function Signature
Fin Bornholt R&D Director

Issued: May 21, 2008

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Calibration Laboratory of
Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
C Service suisse d'étalonnage
S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)
The Swiss Accreditation Service is one of the signatories to the EA
Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: SCS 108

Glossary

DAE	data acquisition electronics
Connector angle	information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement*: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle*: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity*: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity*: Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation*: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted*: Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement*: Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current*: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance*: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage*: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption*: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = $6.1\mu V$, full range = $-100...+300 mV$

Low Range: 1LSB = $61nV$, full range = $-1.....+3mV$

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	$404.509 \pm 0.1\% (k=2)$	$404.928 \pm 0.1\% (k=2)$	$405.207 \pm 0.1\% (k=2)$
Low Range	$3.98477 \pm 0.7\% (k=2)$	$3.94731 \pm 0.7\% (k=2)$	$3.98878 \pm 0.7\% (k=2)$

Connector Angle

Connector Angle to be used in DASY system	$316^\circ \pm 1^\circ$
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Appendix

1. DC Voltage Linearity

High Range		Input (μ V)	Reading (μ V)	Error (%)
Channel X	+ Input	200000	199999.5	0.00
Channel X	+ Input	20000	20003.57	0.02
Channel X	- Input	20000	-19999.29	0.00
Channel Y	+ Input	200000	199999.4	0.00
Channel Y	+ Input	20000	20003.45	0.02
Channel Y	- Input	20000	-20004.32	0.02
Channel Z	+ Input	200000	199999.8	0.00
Channel Z	+ Input	20000	20002.50	0.01
Channel Z	- Input	20000	-20004.27	0.02

Low Range		Input (μ V)	Reading (μ V)	Error (%)
Channel X	+ Input	2000	2000	0.00
Channel X	+ Input	200	200.27	0.13
Channel X	- Input	200	-199.47	-0.27
Channel Y	+ Input	2000	1999.9	0.00
Channel Y	+ Input	200	199.26	-0.37
Channel Y	- Input	200	-199.82	-0.09
Channel Z	+ Input	2000	2000	0.00
Channel Z	+ Input	200	199.19	-0.41
Channel Z	- Input	200	-200.77	0.39

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μ V)	Low Range Average Reading (μ V)
Channel X	200	4.20	4.06
	-200	-2.14	-1.85
Channel Y	200	6.39	6.01
	-200	-6.03	-5.79
Channel Z	200	-4.80	-5.16
	-200	4.08	4.80

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μ V)	Channel Y (μ V)	Channel Z (μ V)
Channel X	200	-	1.42	0.07
Channel Y	200	1.22	-	3.06
Channel Z	200	-1.13	1.08	-

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	16182	17365
Channel Y	15398	16603
Channel Z	16047	16211

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10MΩ

	Average (µV)	min. Offset (µV)	max. Offset (µV)	Std. Deviation (µV)
Channel X	1.05	-1.09	2.60	0.50
Channel Y	-0.43	-2.28	1.41	0.66
Channel Z	-0.33	-2.83	1.40	0.56

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	198.9
Channel Y	0.2000	197.7
Channel Z	0.1999	196.5

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

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ANNEX I : THE EUT APPEARANCES AND TEST CONFIGURATION



8-a : DUT - front view



8-b : Battery - rear view

Picture 6: Constituents of the sample

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Picture 7: Left Hand Touch Cheek Position



Picture 8: Left Hand Tilt 15 Degree Position

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Picture 9: Right Hand Touch Cheek Position



Picture 10: Right Hand Tilt 15 Degree Position

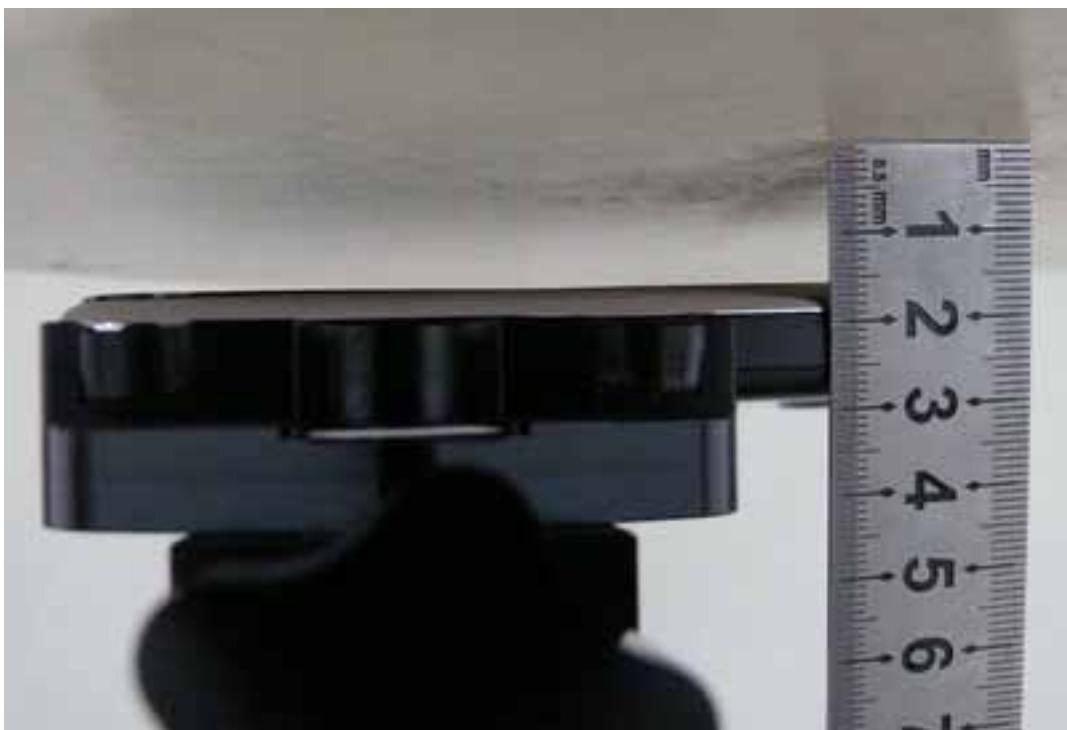
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Picture 11: Body, The EUT display towards ground, the distance from handset to the bottom of the Phantom is 15mm)



Picture 12: Body, towards phantom, the distance from handset to the bottom of the Phantom is 15mm)

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Picture 13: Body with the Earphone, towards ground, the distance from handset to the bottom of the Phantom is 15mm)